

**Amendments to the Claims**

1. (Currently Amended) An electrostatic discharge (ESD) protection circuit comprising:

an NMOS transistor connected between an input/output pad and a ground, the NMOS transistor having a parasitic bipolar transistor; and at least one diode connected between the input/output pad and the NMOS transistor, a cathode of said at least one diode being connected to the ground.

2. (Original) The ESD protection circuit of claim 1, wherein an output terminal of the diode is connected to a base of the parasitic bipolar transistor.

3. (Original) The ESD protection circuit of claim 1, wherein the diode is a PN diode.

4. (Original) The ESD protection circuit of claim 1, wherein the at least one diode includes a plurality of N diodes.

5. (Original) The ESD protection circuit of claim 1, wherein the at least one diode includes a plurality of N diodes, and

a count of the diodes N of the plurality of N diodes is determined so as to stop a current flow through the at least one diode during a normal operation of a chip.

6. (Original) The ESD protection circuit of claim 4, wherein, the plurality of N diodes are connected in series to each other in a forward direction.

7. (Original) The ESD protection circuit of claim 4, wherein p+ and n+ junctions of a first diode of the plurality of N diodes are connected to the input/output pad and a p+ junction of a second diode of the plurality of N diodes, respectively,

the second diode through the N-1 diode of the plurality of N diodes are connected such that an n+ junction of each of the second diode through the N-1 diode is connected to the p+ junction of a subsequent diode, and

an n+ junction of an N diode is connected to the substrate.

8. (Currently Amended) An electrostatic discharge (ESD) protection circuit comprising:

an input/output pad;

a plurality of N diodes connected in series between the input/output pad and a substrate of an NMOS transistor; and

the NMOS transistor is connected between the input/output pad and has a parasitic bipolar transistor connected to the plurality of N diodes, the cathode of at least one of said plurality of N diodes being connected to a ground.

9. (Currently Amended) The ESD protection circuit of claim 8, wherein the substrate is a p-type substrate and connected to a said ground.

10. (Original) The ESD protection circuit of claim 8, wherein the plurality of N diodes are PN diodes.

11. (Original) The ESD protection circuit of claim 8, wherein a number of N diodes in the plurality of N diodes is determined so as to stop a current flow through the plurality of N diodes during a normal operation of a chip.

12. (Original) The ESD protection circuit of claim 8, wherein p+ and n+ junctions of a first diode of the plurality of N diodes are connected to the input/output pad and a p+ junction of a second diode of the plurality of N diodes, respectively,

the second diode through the N-1 diodes of the plurality of N diodes are connected such that an n+ junction of each of the second diode through the N-1 diode is connected to the p+ junction of a subsequent diode; and an n+ junction of an N diode is connected to the substrate.

13. (Original) The ESD protection circuit of claim 8, wherein the output terminal from the Nth diode of the plurality of N diodes is connected to the base of the parasitic bipolar transistor.

14. (Currently Amended) An electrostatic discharge (ESD) protection circuit comprising:

an input/output pad;

at least two diodes connected in parallel between the input/output pad and a substrate of an NMOS transistor; and

the NMOS transistor is connected between the input/output pad and has a parasitic bipolar transistor connected to the plurality of N diodes the cathodes of said diodes being connected to a ground.

15. (Currently Amended) The ESD protection circuit of claim 814, wherein the substrate is a p-type substrate and connected to ~~at~~the ground.

16. (Currently Amended) The ESD protection circuit of claim 814, wherein the diodes are PN diodes.

17. (New) An electrostatic discharge (ESD) protection circuit comprising:  
an input/output pad;

a plurality of N diodes connected in series between the input/output pad and a substrate of an NMOS transistor; and

the NMOS transistor is connected between the input/output pad and has a parasitic bipolar transistor connected to the plurality of N diodes, wherein the substrate is a p-type substrate and is connected to a ground.

18. (New) An electrostatic discharge (ESD) protection circuit comprising:  
an input/output pad;  
at least two diodes connected in parallel between the input/output pad and a substrate of an NMOS transistor; and

the NMOS transistor is connected between the input/output pad and has a parasitic bipolar transistor connected to the plurality of N diodes, wherein the substrate is a p-type substrate and is connected to a ground.